MT1303

N-Channel Power MOSFET

30V, 80A, 5.0m Ω

Features

- $R_{DS(on)}$ = 5.0m Ω at V_{GS} = 10V, I_D = 30A
- · Fast Switching Speed
- · Low Gate Charge
- High Performance Trench Technology for Extr emely Low $R_{DS(on)}$
- · High Power and Current Handling Capability
- RoHS Compliant

General Description

This N-Channel MOSFET is produced using MOS-TECH Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

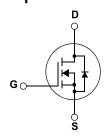
Applications

- · DC-DC primary bridge
- DC-DC Synchronous rectification
- Hot swap



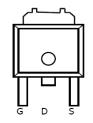
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Simplified Schematic



MARKING DIAGRAM & PIN ASSIGNMENT

TO-252 D-PAK



Top View Drain Connected to Tab

MOSFET Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Absolute Maximum Ratings T _A =25°C unless otherwise noted						
Parameter		Symbol	Maximum	Units		
Drain-Source Voltage		V_{DS}	30	V		
		V_{GS}	±20	V		
Continuous Drain	T _C =25°C		80			
Current ^G	T _C =100°C	I _D	40	A		
Pulsed Drain Current ^C		I _{DM}	150	7		
Avalanche Current ^C		I _{AR}	30	A		
Repetitive avalanche energy L=0.3mH ^C		E _{AR}	135	mJ		
	T _C =25°C	Ь	50	10/		
Power Dissipation ^B	T _C =100°C	$-P_{D}$	25	W		
	T _A =25°C	Ь	3	10/		
Power Dissipation ^A	T _A =70°C	-P _{DSM}	2.1	W		
Junction and Storage	Temperature Range	T _J , T _{STG}	-55 to 175	°C		

Thermal Characteristics						
Parameter	Symbol	Тур	Max	Units		
Maximum Junction-to-Ambient A	t ≤ 10s	− R _{θJA}	15	20	°C/W	
Maximum Junction-to-Ambient A	Steady-State	I \eUA	41	50	°C/W	
Maximum Junction-to-Case B	Steady-State	$R_{\theta JC}$	2.1	3	°C/W	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
MT1303	MT1303	TO-252	-	=	2500

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Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC P	ARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250uA, V _{GS} =0V		30			V
	Z O-t- V-H D O	V_{DS} =20V, V_{GS} =0V				1	
I _{DSS}	Zero Gate Voltage Drain Current		T _J =55°C			5	μΑ
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V				100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		1	1.4	2.5	V
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V		150			Α
_	Otatia Basia Carres On Basiatana	V_{GS} =10V, I_{D} =30A			5	6	
R _{DS(ON)}	Static Drain-Source On-Resistance		T _J =125°C		7.5		mΩ
		V _{GS} =4.5V, I _D =20A			7.6	9.5	
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A			49		S
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V			0.74	1	V
I _S	Maximum Body-Diode Continuous Curre				50	Α	
DYNAMIC	PARAMETERS		·				·
C _{iss}	Input Capacitance				2050	2460	pF
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =12.5V, f=1MHz V_{GS} =0V, V_{DS} =0V, f=1MHz			485		pF
C _{rss}	Reverse Transfer Capacitance				280		pF
R_q	Gate resistance				0.86	1.5	Ω
SWITCHII	NG PARAMETERS						<u>'</u>
Q _g (10V)	Total Gate Charge				34	41	nC
$Q_g(4.5V)$	Total Gate Charge	V _{GS} =10V, V _{DS} =12.5V, I _D =20A			17	22	nC
Q_{gs}	Gate Source Charge				5		nC
Q_{gd}	Gate Drain Charge				3.5		nC
t _{D(on)}	Turn-On DelayTime				7.5		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =12.5V, R_L =0.68 Ω , R_{GEN} =3 Ω			11		ns
$t_{D(off)}$	Turn-Off DelayTime				27		ns
t _f	Turn-Off Fall Time				8		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=100A/μs			30	36	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, dI/dt=100A/μs			19		nC

A: The value of R $_{8JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25°C. The Power dissipation P $_{DSM}$ is based on R $_{8JA}$ and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

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B. The power dissipation P_D is based on T_{J(MAX)}=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T _{J(MAX)}=175°C.

D. The R $_{\text{BJA}}$ is the sum of the thermal impedence from junction to case R $_{\text{BJC}}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 $\,\mu s$ pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T J(MAX)=175°C.

 $[\]ensuremath{\mathsf{G}}.$ The maximum current rating is limited by bond-wires.

H. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T A=25°C. The SOA curve provides a single pulse rating. Rev1: March 2006

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

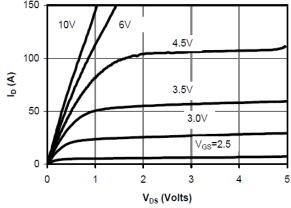


Fig 1: On-Region Characteristics

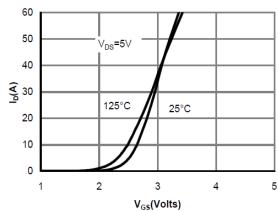


Figure 2: Transfer Characteristics

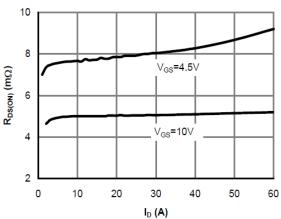


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

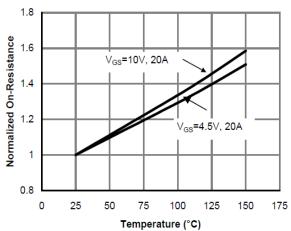


Figure 4: On-Resistance vs. Junction Temperature

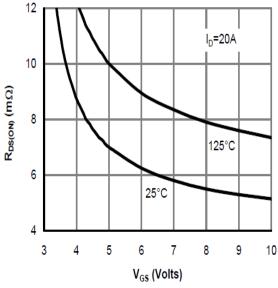


Figure 5: On-Resistance vs. Gate-Source Voltage

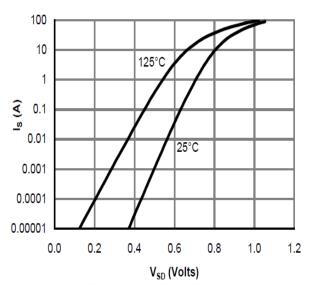


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

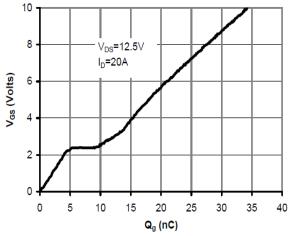


Figure 7: Gate-Charge Characteristics

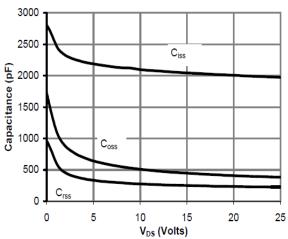


Figure 8: Capacitance Characteristics

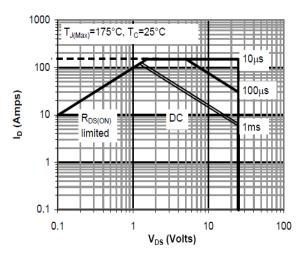


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

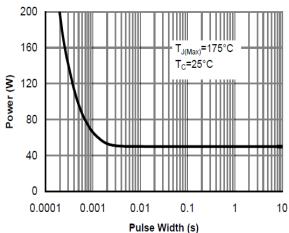


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

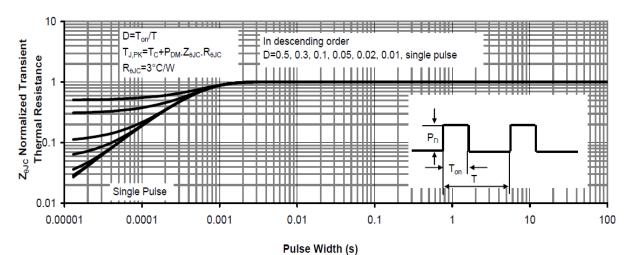


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS 60 60 _{ID}(A), Peak Avalanche Current 50 50 Power Dissipation (W) 40 T_A=25°C 40 30 30 20 20 10 10 0 0.00001 0.0001 0.001 0 25 50 75 100 125 150 175 Time in avalanche, $t_{\rm A}$ (s) T_{CASE} (°C) Figure 12: Single Pulse Avalanche capability Figure 13: Power De-rating (Note B) 50 60 50 40 Current rating I_D(A) 40 Power (W) 20 30 20 10 10 0 0 0.1 0.01 1 100 25 50 75 100 175 10 1000 0 125 150 T_{CASE} (°C) Pulse Width (s) Figure 15: Single Pulse Power Rating Junction-to Figure 14: Current De-rating (Note B) Ambient (Note H) 10 In descending order Z_{eJA} Normalized Transient D=0.5. 0.3. 0.1. 0.05. 0.02. 0.01. single pulse Thermal Resistance 0.1 $D=T_{on}/T$ 0.01 $T_{J,PK} = T_A + P_{DM} \cdot Z_{\theta JA} \cdot R_{\theta JA}$ $R_{\theta JA}$ =50°C/W Single Pulse 0.001 0.00001 0.0001 0.001 0.01 0.1 10 100 1000 Pulse Width (s) Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

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